

AOT482L/AOB482L

80V N-Channel MOSFET SDMOS™

General Description

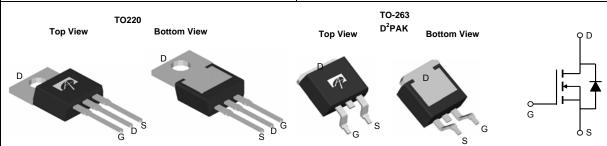
The AOT482L/AOB482L is fabricated with SDMOSTM trench technology that combines excellent $R_{DS(ON)}$ with low gate charge and low Q_{rr} . The result is outstanding efficiency with controlled switching behavior. This universal technology is well suited for PWM, load switching and general purpose applications.

Product Summary

 $\begin{array}{lll} V_{DS} & 80V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 105A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 7.2 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 7V) & < 9 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested





| Absolute Maximum Ratings T _A =25°C unless otherwise noted | | | | | | |
|--|-----------------------|-----------------------------------|------------|-------|--|--|
| Parameter | | Symbol | Maximum | Units | | |
| Drain-Source Voltage | | V _{DS} | 80 | V | | |
| Gate-Source Voltage | | V _{GS} | ±25 | V | | |
| Continuous Drain | T _C =25°C | | 105 | | | |
| Current G | T _C =100°C | I _D | 82 | A | | |
| Pulsed Drain Current ^c | | I _{DM} | 330 | | | |
| Continuous Drain | T _A =25°C | | 11 | A | | |
| Current | T _A =70°C | I _{DSM} | 9 | A | | |
| Avalanche Current ^C | | I _{AS} , I _{AR} | 82 | A | | |
| Avalanche energy L=0.1mH ^C | | E _{AS} , E _{AR} | 336 | mJ | | |
| | T _C =25°C | В | 333 | W | | |
| Power Dissipation B | T _C =100°C | — P _D — | 167 | VV | | |
| | T _A =25°C | В | 2.1 | W | | |
| Power Dissipation A | T _A =70°C | P _{DSM} | 1.3 | ¬ vv | | |
| Junction and Storage Temperature Range | | T _J , T _{STG} | -55 to 175 | °C | | |

| Thermal Characteristics | | | | | | | |
|--------------------------------|--------------|-----------------|------|-------|------|--|--|
| Parameter | Symbol | Тур | Max | Units | | | |
| Maximum Junction-to-Ambient A | t ≤ 10s | $R_{\theta JA}$ | 11 | 15 | °C/W | | |
| Maximum Junction-to-Ambient AD | Steady-State | ГХ⊕ЈД | 47 | 60 | °C/W | | |
| Maximum Junction-to-Case | Steady-State | $R_{\theta JC}$ | 0.36 | 0.45 | °C/W | | |



Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | | Min | Тур | Max | Units |
|---------------------------|---|---|-----------------------|----------|-----------|-----------|----------|
| STATIC F | PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | | 80 | | | V |
| I _{DSS} | Zara Cata Valtaga Drain Current | V _{DS} =80V, V _{GS} =0V | | | | 10 | |
| | Zero Gate Voltage Drain Current | | | | | 50 | μΑ |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} = ±25V | | | | 100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage | V _{DS} =V _{GS} I _D =250μA | | 2.5 | 3.1 | 3.7 | V |
| I _{D(ON)} | On state drain current | V _{GS} =10V, V _{DS} =5V | | 330 | | | Α |
| | | V_{GS} =10V, I_D =20A | | | 5.9 | 7.2 | mΩ |
| | | TO220 | T _J =125°C | | 11 | 13 | |
| | | V_{GS} =7V, I_D =20A | • | | | | |
| R _{DS(ON)} | Static Drain-Source On-Resistance | TO220 | | | 6.8 | 9 | mΩ |
| BS(GN) | | V_{GS} =10V, I_D =20A | | | | | |
| | | TO263 | | | 5.6 | 6.9 | mΩ |
| | | V_{GS} =7V, I_D =20A | | 0.5 | 0.7 | | |
| 0 | Forward Transconductance | TO263 V _{DS} =5V, I _D =20A | | | 6.5 50 | 8.7 | mΩ S |
| g _{FS} | Diode Forward Voltage | | | 0.64 | 1 | V | |
| V _{SD} | Maximum Body-Diode Continuous Curr | I _S =1A,V _{GS} =0V | | 0.04 | 105 | A | |
| 0 | · | CIIL | | | | 103 | _ ^ |
| Ciss | Input Capacitance | | | 3240 | 4054 | 4870 | pF |
| C _{oss} | Output Capacitance | V _{GS} =0V, V _{DS} =40V, f=1MHz | | 3240 | 458 | 600 | рF |
| C _{rss} | Reverse Transfer Capacitance | | | 95 | 160 | 225 | рF |
| R _a | Gate resistance | | | 0.2 | 0.45 | 0.7 | Ω |
| , | | V _{GS} -0V, V _{DS} -0V, I-1 | IVII IZ | 0.2 | 0.43 | 0.7 | 52 |
| $Q_g(10V)$ | NG PARAMETERS Total Gate Charge | | | 53 | 66.8 | 81 | nC |
| Q _g (10V) | Gate Source Charge | V _{GS} =10V, V _{DS} =40V, I _D =20A | | 16 | 20.8 | 25 | nC |
| | Gate Drain Charge | | | 12 | 20.0 | 30 | nC |
| Q _{gd} | Turn-On DelayTime | | | 12 | 26 | 30 | ns |
| $\frac{t_{D(on)}}{t_{r}}$ | Turn-On Rise Time | _ V _{GS} =10V, V _{DS} =40V, I | P. =20 | | 18 | | ns |
| | Turn-Off DelayTime | $R_{GEN}=3\Omega$ | | | 48 | | ns |
| $t_{D(off)}$ t_f | Turn-Off Fall Time | | | | 21 | | ns |
| t _{rr} | | I _F =20A, dI/dt=500A/μ | e | 10 | | 24 | |
| Q _{rr} | Body Diode Reverse Recovery Time Body Diode Reverse Recovery Charge | <u>, ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' '</u> | | 18 75 | 26 108 | 34 140 | ns nC |
| | e of R _{0.14} is measured with the device mounted on 1 | | | | | | |

A. The value of $R_{\theta,M}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The Power dissipation P_{DSM} is based on $R_{\theta,M}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

- D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=175^{\circ}C$. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =175°C. Ratings are based on low frequency and duty cycles to keep initial T_J =25°C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

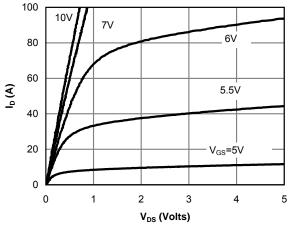


Fig 1: On-Region Characteristics (Note E)

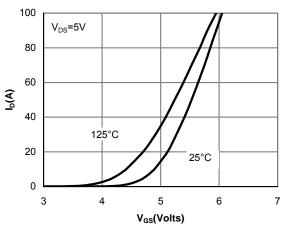


Figure 2: Transfer Characteristics (Note E)

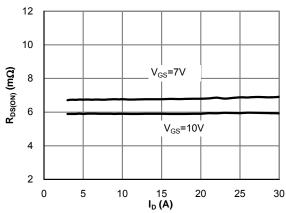


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

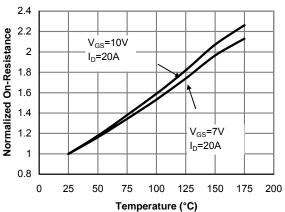


Figure 4: On-Resistance vs. Junction Temperature (Note E)

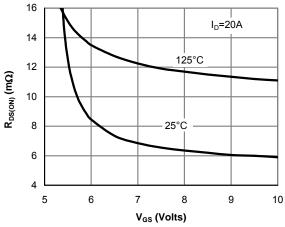


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

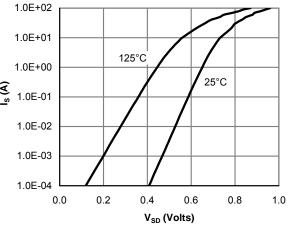


Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

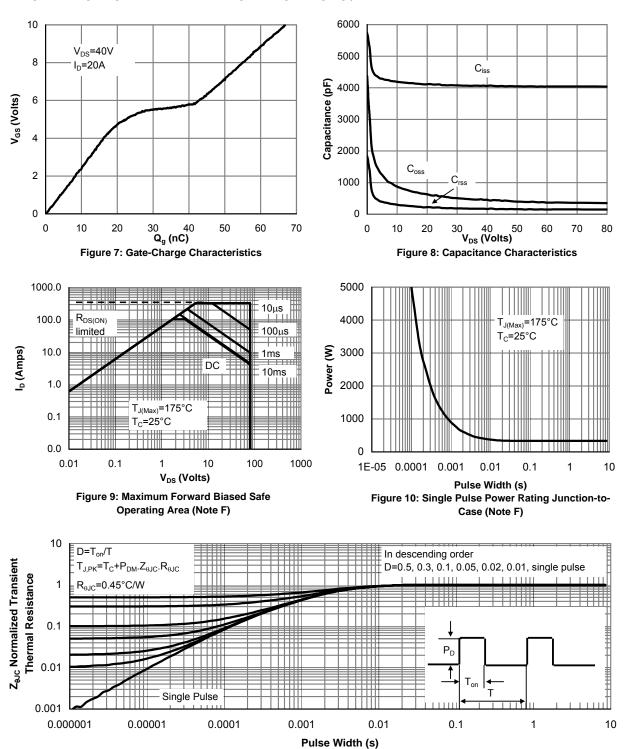


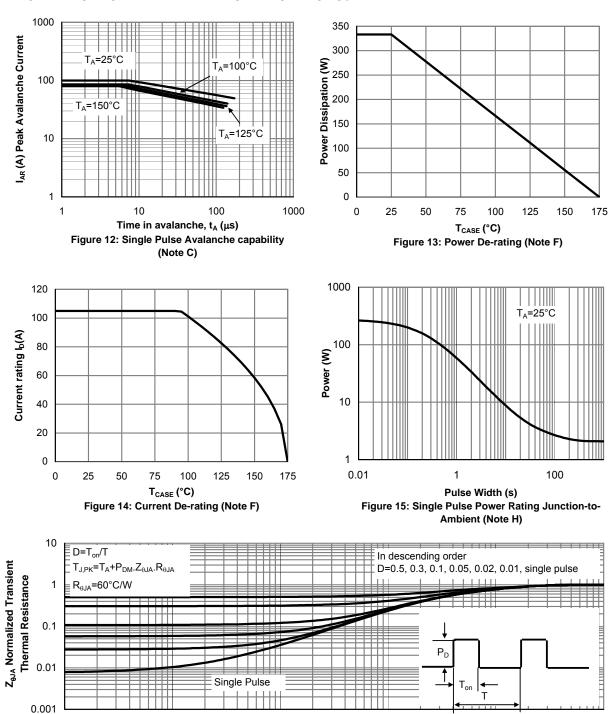
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

1000



0.01

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

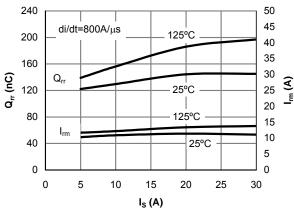


Figure 17: Diode Reverse Recovery Charge and Peak Current vs. Conduction Current

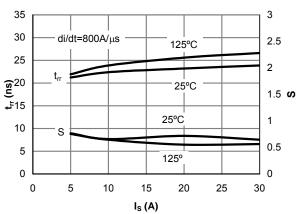


Figure 18: Diode Reverse Recovery Time and Softness Factor vs. Conduction Current

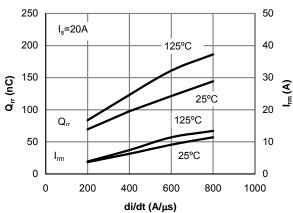


Figure 19: Diode Reverse Recovery Charge and Peak Current vs. di/dt

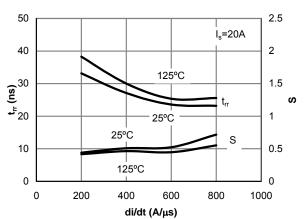
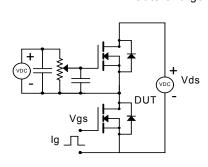
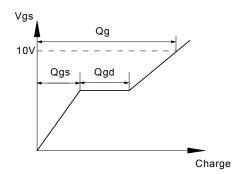


Figure 20: Diode Reverse Recovery Time and Softness Factor vs. di/dt

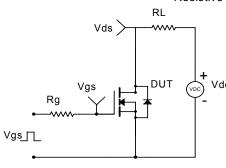


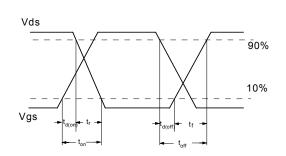
Gate Charge Test Circuit & Waveform



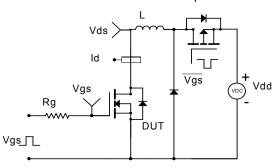


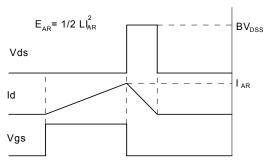
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

